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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of:

Alan G. Wood
Tim J. Corbett
Gary L. Chadwick
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Continuation of Serial No. 08/192,023 Art Unit:
filed February 3, 1994

Filing Date: July 10, 2000 Examiner:

For: Test Fixture And Test Method For Testing
Semiconductor Dice (As Amended)

Attorney Docket No. 91-62.20

**PRELIMINARY AMENDMENT
SUBMITTED WITH CONTINUING APPLICATION
UNDER 37 CFR 1.53(b)
July 10, 2000**

Commissioner of Patents and Trademarks
BOX PATENT APPLICATION
Washington, D.C. 20231

Sir:

This Preliminary Amendment is being filed with a continuing application under 37 CFR 1.53(b). Please amend the captioned case as follows.

In the Specification

Please change the title to --Test Fixture And Test Method For Testing Semiconductor Dice--.

On page 2, line 1, please add the following:

--Cross Reference To Related Applications

This application is a continuation of application serial no. 08/192,023, filed February 3, 1994, Patent No. 6,091,250, which is a division of application serial no.

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